

A MILLIMETER-WAVE PASSIVE FET SWITCH USING IMPEDANCE TRANSFORMATION NETWORKS

FIELD OF THE INVENTION

5 The present invention relates to a signal switch network, in particular, a millimeter-wave passive FET (Field Effect Transistor) switch using impedance transformation networks.

BACKGROUND OF THE INVENTION

10 High frequency switch is one of the important devices in MMW (millimeter-wave) radio communication system. The performance of a circuit is limited by the devices used in the circuit. As to the high frequency switch used in millimeter-wave band, the isolation of the switch in on/off state is limited by the FET used in the switch. Since 15 in high frequency, an FET in off state will present low impedance instead of high impedance due to the capacitance between the drain and source of the FET. In addition, high frequency signals between neighbor transmission lines will often couple with one another so as to degrade the performance of the circuit.

20 Monolithic PIN diode microwave switch has demonstrated excellent performance even up to millimeter-wave frequency. However, since PIN diode cannot be manufactured in MMIC (Monolithic Microwave Integrated Circuit) process of HEMT (High Electron Mobility Transistor, one type of FET), FET switch is still 25 very popular today, because FET can be integrated with other building blocks in a transmit/receive (T/R) module, and presents better linearity than PIN diode. For frequency of 20 GHz or lower,

series and/or shunt configurations of an FET with a transmission line can readily serve as a very good switch with excellent isolation and insertion loss. However, for frequency higher than 20 GHz, the parasitic capacitance between the drain and the source of FET will

5 degrade the isolation performance significantly. Most MMW monolithic FET switches employ inductors to resonate with the parasitic capacitance between the drain and the source of FET, but the isolation of the switch is still lower than 30dB (please see references [1]~[4]).

10 In order to enhance the isolation of the switch, a transmission line with quarter wavelength is used to increase the distance between the switch and the signal line, so as to achieve up to 44 dB isolation (please see reference [5]), but a huge chip area is required, and therefore increase the cost.

15 Phase cancellation technique of Lange coupler can also be used to achieve a better isolation performance (please see reference [6]), but several 3 dB and 90° Lange couplers are required, and thus increase the layout area.

Recently, compact DC~60 GHz HJFET MMIC switch was
20 reported with reasonable isolation performance (please see references [7]~[8]), but a special process/layout for the ohmic electrode sharing technology is required in HEMT devices.

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OBJECT OF THE INVENTION

It is therefore an object of the present invention to provide a millimeter-wave passive FET switch using impedance transformation networks, utilizing the standard HEMT manufacturing process to reduce the layout of the chip, and to enhance the performance of the high frequency switch.

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BRIEF DESCRIPTION OF THE DRAWINGS

Fig. 1 shows schematically the network of a conventional millimeter-wave switch.

Fig. 2 shows schematically the network of the millimeter-wave switch according to the present invention by adding impedance transformation network.

Fig. 3 shows schematically the impedance transformation in Smith Chart of the millimeter-wave switch according to the present invention.

Fig. 4 shows schematically a complete single pole double through (SPDT) millimeter-wave switch according to the present invention.

DESCRIPTION OF THE INVENTION

Conventionally a microwave switch is designed by adding an FET or a diode series/shunt connected with the signal lines. The impedance of the FET/diode is controlled by voltage so as to achieve open/short function of the switch.

Referring to Fig. 1, an FET T1 is shunt connected with the signal line SL, in which the gate G of the FET T1 is connected with a control voltage V to control the impedance between the drain D and the source S of FET T1. The drain D and the source S are connected parallelly with the signal line SL and to the ground.

For lower frequencies, since FET T1 demonstrates excellent performance, the shunt connection has no problem at all. However, for MMW frequencies, when the voltage V tries to change the FET T1 into open circuit, since the parasitic capacitance between the drain D and the source S causes FET T1 to present low impedance instead of high impedance, therefore the isolation performance of the passive FET is degraded significantly.

In order to enhance the performance of the switch, the present invention employs impedance transformation networks to be parallelly connected with the signal line SL, as shown in Fig. 2. The equivalent impedance seen at point A is $A(\text{on})$, $A(\text{off})$ as shown in the Smith Chart of Fig. 3. There is no impedance transformation network added, as the same configuration in Fig. 1.

First, a first transmission line Step 1 is series connected with the
 25 FET T1, the equivalent impedance seen at point B is $Z_{B(on)}$, $Z_{B(off)}$ as
 shown in the Smith Chart of Fig. 3.

Next, a second transmission line Step 2 is parallelly connected,

the equivalent impedance seen at point C is C(on), C(off) as shown in the Smith Chart of Fig. 3.

Finally, a third transmission line Step 3 is series connected, the equivalent impedance seen at point D is D(on), D(off) as shown in
5 the Smith Chart of Fig. 3.

By the three steps of impedance transformation, it is apparent
that the equivalent impedance seen from the signal line SL is
transferred from A(on), A(off) to D(on), D(off) in the Smith Chart of
Fig. 3. This proves that an excellent switching performance is
10 achieved by adding the impedance transformation networks to the
FET T1. It is noted that point D(on) represents a high impedance
(near open circuit), while D(off) is a low impedance (near short
circuit).

A complete single pole double through (SPDT) switch is shown
15 in Fig. 4.

Two monolithic microwave switch ICs are manufactured
successfully according to the present invention, and it demonstrates
excellent switching performance, while the size thereof is only 1×2
mm² (please see reference [9]), much smaller than the conventional
20 size of 2×5 mm² (please see reference [5]).

The connection of impedance transformation networks Step 1,
Step 2, Step 3 with FET T1 in Fig. 2 can be series connected with the
signal line SL instead of parallel connected.

The spirit and scope of the present invention depend only upon
25 the following Claims, and are not limited by the above embodiments.